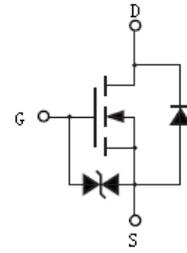


### Features

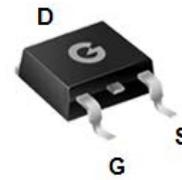
- Very low FOM  $R_{DS(on)} \times Q_G$
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested
- Built-in ESD Diode
- Multi-epi process

HF



### APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- TV power & LED Lighting Power
- AC to DC Converters
- Telecom



TO-252

### Mechanical Data

- Case: TO-252
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208

### Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
SJM60R490D	TO-252	80 pcs / Tube or 2500 pcs / Tape & Reel	SJM60R490D

### Maximum Ratings (@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS}$	600	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current ( $T_C = 25^\circ\text{C}$ ) *1	$I_D$	8	A
Continuous Drain Current ( $T_C = 100^\circ\text{C}$ ) *1		5.1	A
Pulsed Drain Current *1	$I_{DM}$	24	A
Single Pulse Avalanche Energy *2	$E_{AS}$	98	mJ
Gate Source ESD (HBM-C=100pF, R = 1.5k $\Omega$ )	$V_{ESD(G-S)}$	2000	V

### Thermal Characteristics

Parameter	Symbol	Value	Unit
Power Dissipation ( $T_C = 25^\circ\text{C}$ )	$P_D$	70	W
Thermal Resistance Junction-to-Air	$R_{\theta JA}$	62.5	$^\circ\text{C/W}$
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	1.79	$^\circ\text{C/W}$
Operating Junction Temperature Range	$T_J$	-55 ~ +150	$^\circ\text{C}$
Storage Temperature Range	$T_{STG}$	-55 ~ +150	$^\circ\text{C}$

### Electrical Characteristics (@ $T_J = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 1mA$	600	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 600V, V_{GS} = 0V$	-	-	1	$\mu\text{A}$
		$V_{DS} = 600V, T_C = 150^\circ\text{C}$	-	-	100	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	$\pm 1$	$\mu\text{A}$
<b>On Characteristics</b>						
$R_{DS(ON)}$	Static Drain-Source On-resistance	$V_{GS} = 10V, I_D = 2.6A$	-	-	0.49	$\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2.0	-	4.0	V
<b>Dynamic Characteristics</b>						
$C_{ISS}$	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 400V$ $f = 1.0\text{MHz}$	-	680	-	pF
$C_{OSS}$	Output Capacitance		-	20	-	
$C_{RSS}$	Reverse Transfer Capacitance		-	2.4	-	
<b>Switching Characteristics</b>						
$t_{d(ON)}$	Turn-on Delay Time	$V_{DS} = 300V$ $R_G = 25\Omega$ $I_D = 3.3A^{*3,4}$	-	25	-	ns
$t_r$	Turn-on Rise Time		-	19	-	
$t_{d(OFF)}$	Turn-Off Delay Time		-	87	-	
$t_f$	Turn-Off Fall Time		-	18	-	
$Q_G$	Total Gate-Charge	$V_{DS} = 480V$ $V_{GS} = 10V$ $I_D = 3.3A^{*3,4}$	-	16	-	nC
$Q_{GS}$	Gate to Source Charge		-	3.1	-	
$Q_{GD}$	Gate to Drain (Miller) Charge		-	5.2	-	
<b>Source-Drain Diode Characteristics</b>						
$V_{SD}$	Diode Forward Voltage	$I_S = 3.3A, V_{GS} = 0V$	-	-	1.3	V
$I_S$	Diode Continuous Forward Current		-	-	8	A
$I_{SM}$	Pulsed Source-Drain Current		-	-	24	A
$t_{rr}$	Reverse Recovery Time	$I_F = 3.3A, V_R = 400V$ $di_F/dt = 100A/\mu\text{s}$	-	250	-	ns
$Q_{rr}$	Reverse Recovery Charge		-	1.9	-	$\mu\text{C}$

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $I_{AS} = 1.5A$ ,  $V_{DD} = 50V$ ,  $R_G = 25\Omega$ , Starting  $T_J = 25^\circ C$
3. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$
4. Essentially Independent of Operating Temperature

Ratings and Characteristics Curves (@  $T_A = 25^\circ C$  unless otherwise specified)

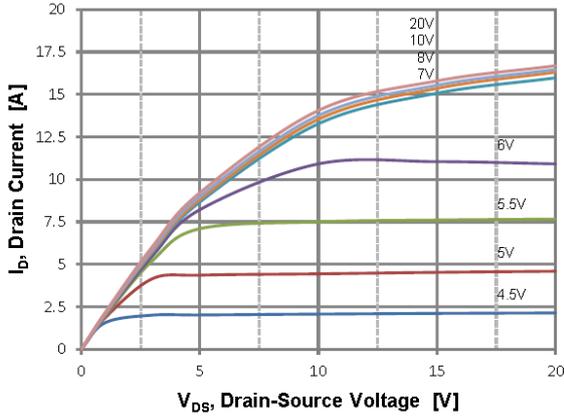


Figure 1. On Region Characteristics

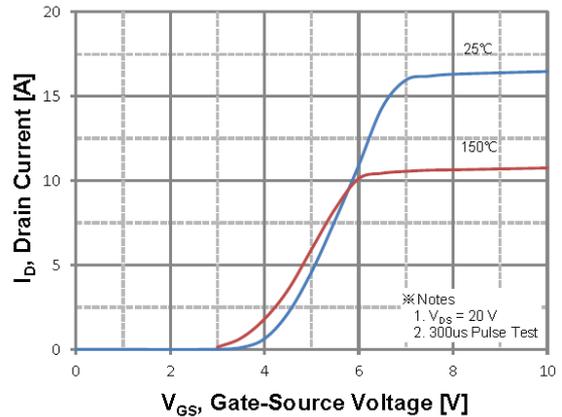


Figure 2. Transfer Characteristics

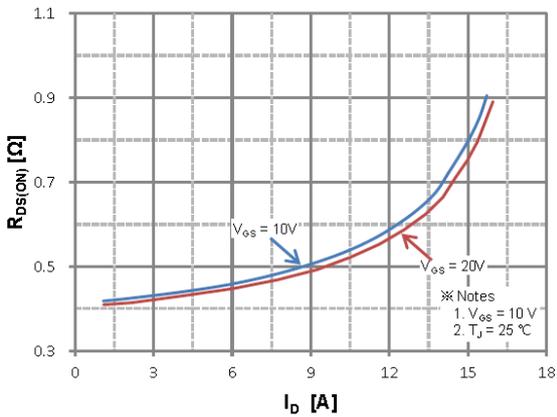


Figure 3. On Resistance Variation vs Drain Current and Gate Voltage

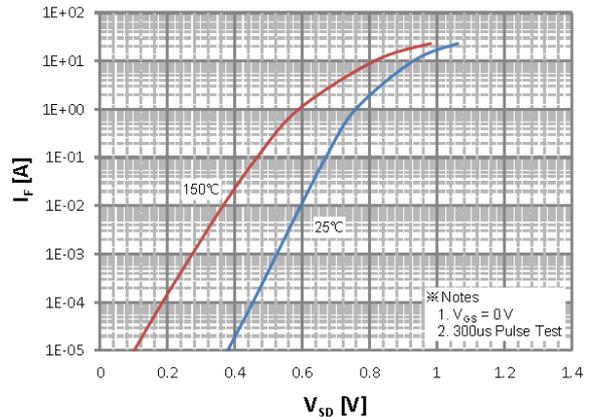


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

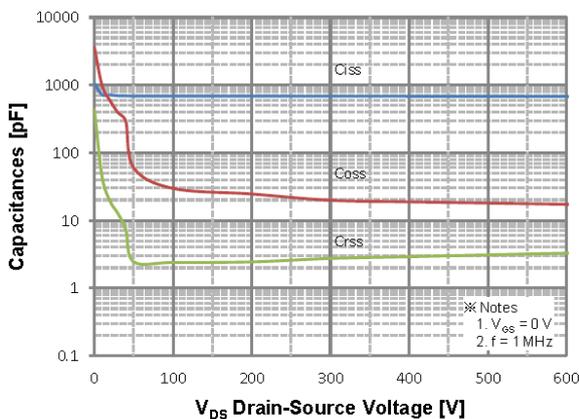


Figure 5. Capacitance Characteristics

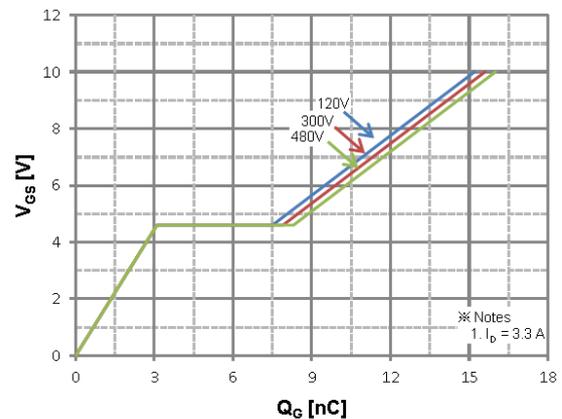


Figure 6. Gate Charge Characteristics

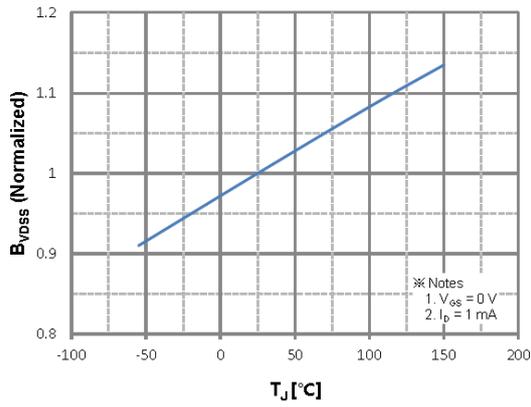


Figure 7. Breakdown Voltage Variation vs. Temperature

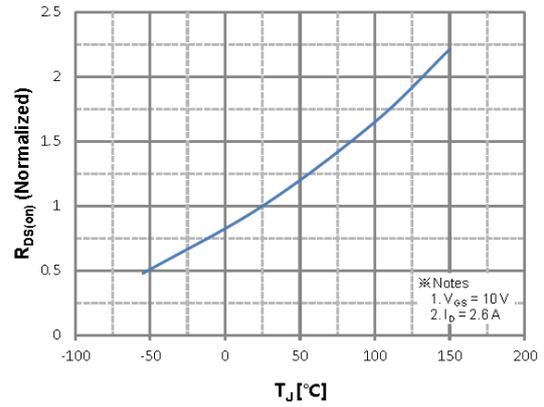


Figure 8. On-Resistance Variation vs. Temperature

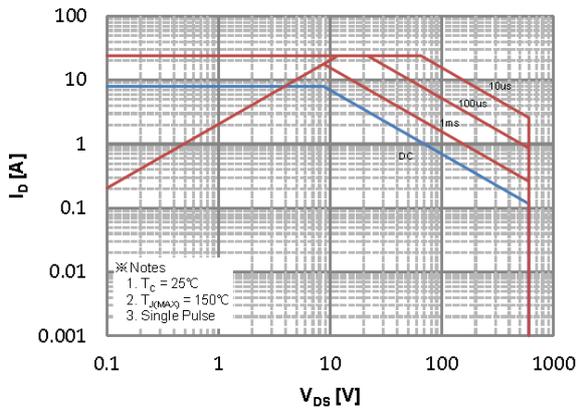


Figure 9. Maximum Safe Operating Area

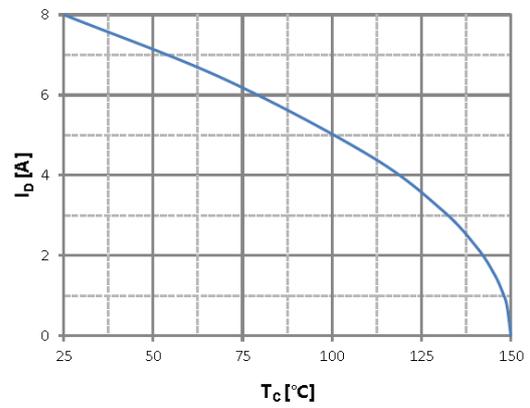
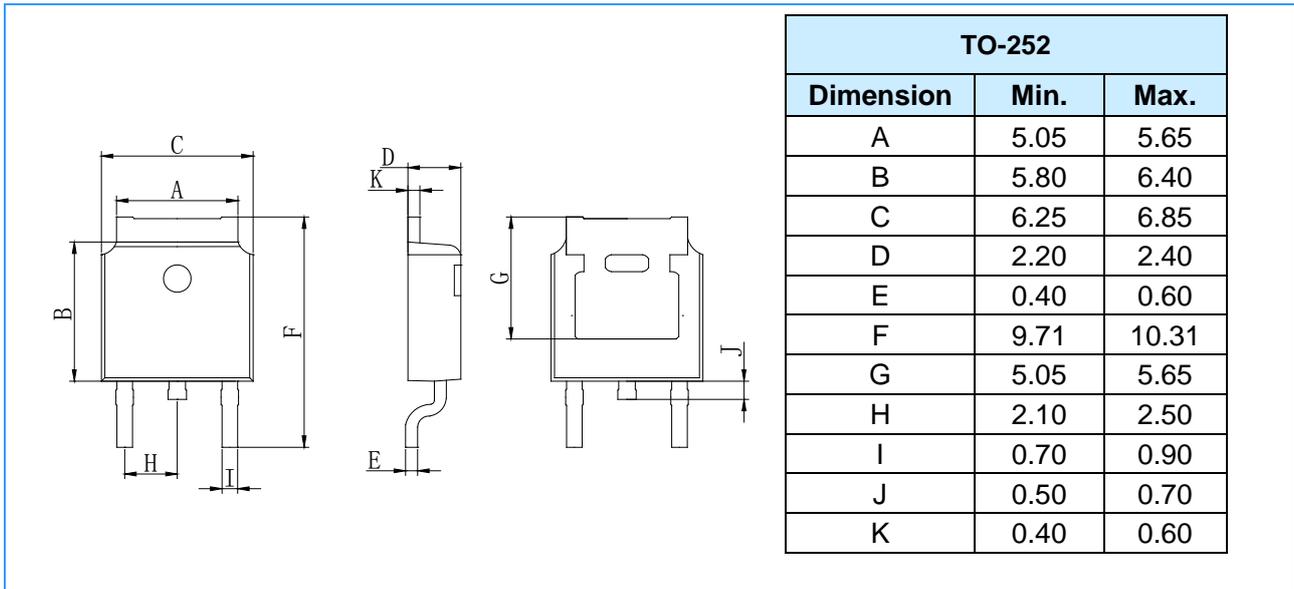
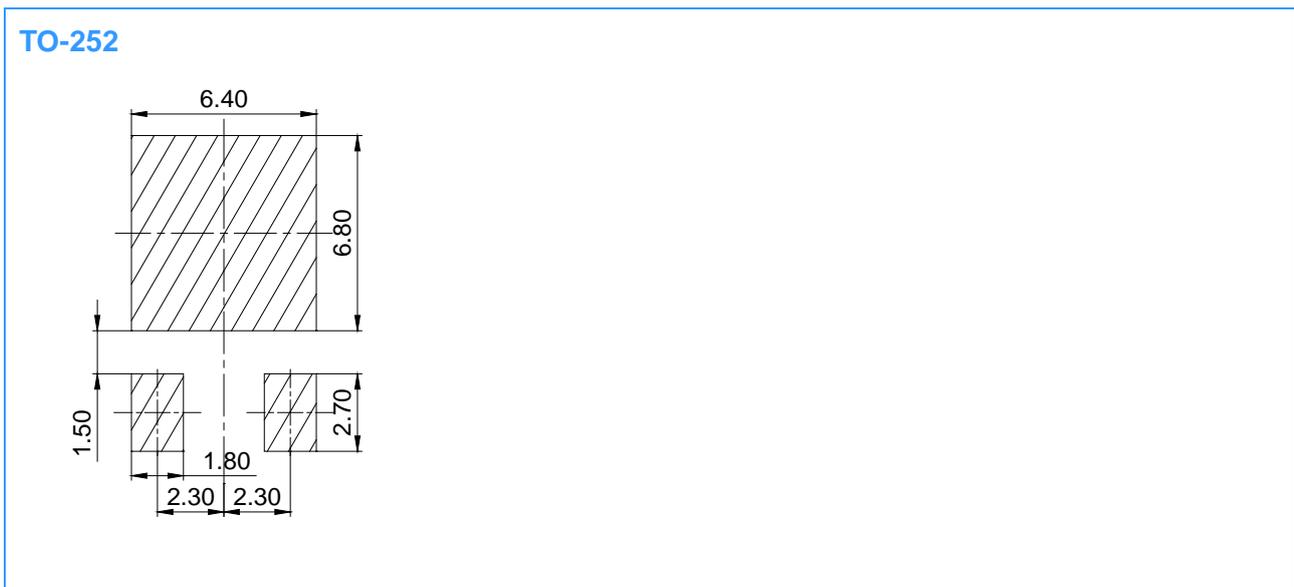


Figure 10. Maximum Drain Current vs. Case Temperature

**Package Outline Dimensions** (Unit: mm)



**Mounting Pad Layout** (Unit: mm)



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